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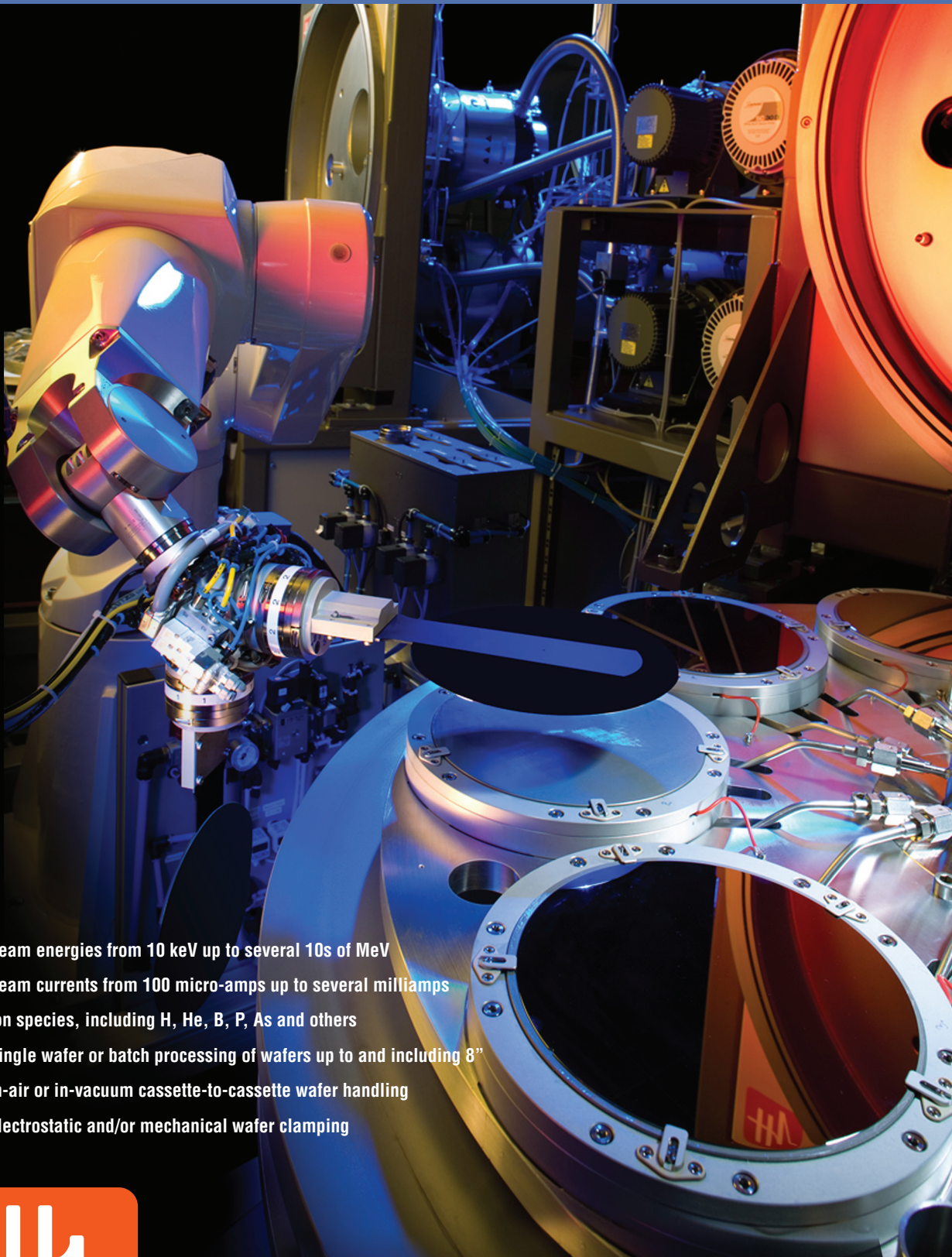
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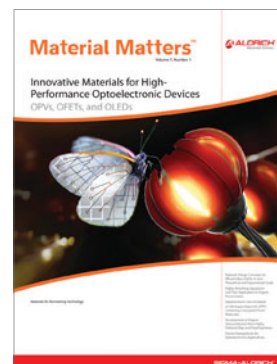
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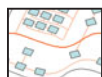


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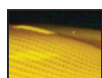
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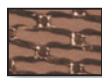
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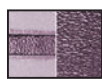
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ON THE COVER

Materials for stretchable electronics. This issue of *MRS Bulletin* highlights stretchable electronics, the latest research frontier in large-area electronics. The cover shows an artistic rendering of electronic skin, conforming to irregularly curved surfaces and incorporating arrays of thin-film devices and integrated circuits. Electronic skin typically consists of diverse materials spanning more than 12 orders of magnitude in elastic modulus. The general architecture of an electronic skin is illustrated in the image, with a soft elastomeric substrate bearing stiff islands. The circuits on the islands include light-emitting diodes and are interconnected with elastic meander-shaped metallic conductors. The cover image is courtesy of Georg Wieser. See the technical theme that begins on page 207.



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The Society's interdisciplinary approach differs from that of single-discipline professional societies because it promotes information exchange across the many technical fields touching materials development. MRS sponsors three major international annual meetings encompassing approximately 125 topical symposia, and also sponsors numerous single-topic scientific meetings. The Society recognizes professional and technical excellence and fosters technical interaction in local geographic regions through Sections and University Chapters.

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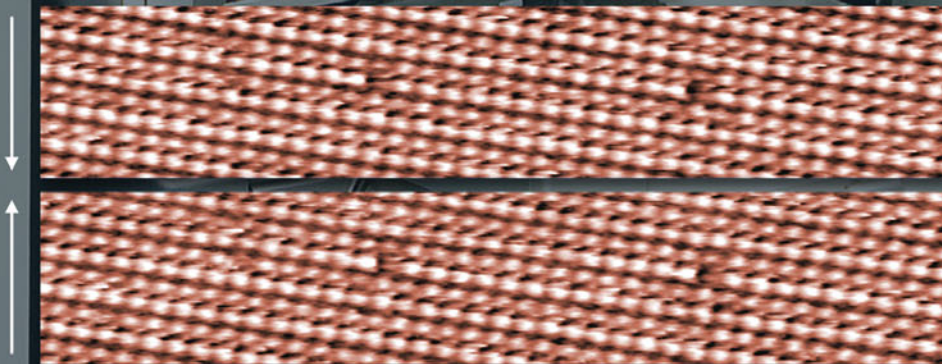
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